



Article

A Systematical Characterization of $\text{TeO}_2\text{--V}_2\text{O}_5$ Glass System Using Boron (III) Oxide and Neodymium (III) Oxide Substitution: Resistance Behaviors against Ionizing Radiation

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Abstract: This study aimed to perform an extensive characterization of a $74.75\text{TeO}_2\text{--}0.25\text{V}_2\text{O}_5\text{--}(25 - x)\text{B}_2\text{O}_3\text{--}x\text{Nd}_2\text{O}_3$ glass system with ($x = 0, 0.5, 1.0$, and 1.5 mol%) for radiation shielding properties. Linear and mass attenuation coefficients were determined using Phy-X PSD software and compared with the simulation using Monte Carlo software MCNPX (version 2.7.0). Half value layer, mean free path, tenth value layer, effective atomic number, exposure buildup factor, and energy absorption buildup factors of VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 glasses were determined, respectively. The results showed that boron (III) oxide and neodymium (III) oxide substitution has an obvious impact on the gamma ray attenuation properties of the studied glasses. It can be concluded that the VTBNd1.5 sample with the highest content of neodymium (III) oxide (1.5 mol%) is the superior sample for shielding of gamma radiation in the investigated energy range.

Keywords: MCNPX; neodymium (III) oxide; ionizing radiation; Phy-X PSD

1. Introduction

The multitude of physical, thermal, optical, and structural properties of glasses make them far better than other goods. They are manufactured easily at different temperatures, which led to the increase in studies where they were used in optoelectronic devices and in other industries. A large number of these experiments are dedicated to glasses comprising rare earth metal oxides [1–3]. These low-cost glasses are ideal hosts for rare earth elements and are excellent materials for optoelectronics. Tellurium oxide (TeO_2), the source material for tellurite glasses, acts as the network former in the matrix as it is combined with alkali metals, alkaline earth metals, intermediate metals, or other glass formers to form the glass [4]. Tellurium glasses exhibit low melting temperatures, high transmittance, high refractive indices, and chemical and mechanical tolerance.

In comparison, tellurium oxide glasses are equivalent to others in electrical conductivity, and have strong dielectric constants [5,6]. In addition to basic studies in which crystallization of binary and pure tellurite glasses were conducted, there are also important dielectric, structural, and radiation shielding studies reported. People expect glasses that involve transition metal oxides to be semiconducting [7]. In experiments, added metallic

oxides produce a promising performance. Adding such insoluble metals to tellurium-based glasses greatly drives the creation of semiconducting materials. Vanadium pentoxide occurs as a glassmaker with semiconducting properties in the glasses, making it a reasonable option for a wide variety of applications [7,8]. It was recently shown that these glasses could have a high degree of radiation protection [9–12]. Previously, Elmahroug et al. investigated the radiation shielding properties for a $\text{Bi}_2\text{O}_3\text{--V}_2\text{O}_5\text{--TeO}_2$ glass system in the energy range of 0.356–1.33 MeV. Their results showed that increasing Bi_2O_3 in a $\text{V}_2\text{O}_5\text{--TeO}_2$ glass system leads to an increment in shielding competencies [13]. In fact, the use of glass materials for radiation shielding is not limited to this type of glass, but the frequency of research has been increasing day by day as a hot subject emphasized in many similar studies in recent years [14–18].

Some of the reasons for this situation are that some traditional materials such as lead and concrete used in radiation fields do not have superior material properties and have some characteristics that threaten health. Of course, although this does not show that they are an inadequate radiation shielding material, some international institutions and organizations have direct incentives for researchers to study new generation shielding materials that can be an alternative to these materials with their eco-friendly and promising properties. In this case, glasses can be considered as a strong candidate for these types of utilizations. In this study, a group of glasses encoded VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 based on a $\text{TeO}_2\text{--V}_2\text{O}_5\text{--(B}_2\text{O}_3/\text{Nd}_2\text{O}_3)$ glass composition were extensively investigated in terms of their gamma and neutron radiation attenuation competencies [1]. To the best of our knowledge, no extensive gamma-ray shielding characterization has been done using advanced simulation methods and numerical comparison $\text{TeO}_2\text{--V}_2\text{O}_5\text{--(B}_2\text{O}_3/\text{Nd}_2\text{O}_3)$. Therefore, this study aimed to perform a detailed characterization on the aforementioned glass composition, which could be very useful to understand the competencies of studied glass samples in medical and industrial radiation facilities. Moreover, this study aimed to discuss the potential effects of $\text{B}_2\text{O}_3/\text{Nd}_2\text{O}_3$ substitution on nuclear radiation shielding properties. Therefore, another important point to highlight is the concept of investigation that additive replacement effects will be evaluated with details. Some of the investigated parameters can be listed as linear attenuation coefficients (LAC), mass attenuation coefficients (MAC), Effective electron density (N_{eff}), Half value layer ($T_{1/2}$), Exposure buildup factor (EBF) and energy absorption buildup factor (EABF), tenth value layer (TVL), mean free path (λ), and effective atomic number (Z_{eff}). The obtained outcomes from the current investigation would be useful to understand the direct impact of the glass structure and density as well as the replacement type on radiation shielding properties of a $\text{TeO}_2\text{--V}_2\text{O}_5\text{--(B}_2\text{O}_3/\text{Nd}_2\text{O}_3)$ system.

2. Materials and Methods

2.1. Simulation Studies for Gamma-ray Transmission

Mass attenuation coefficients (MAC) of the $74.75\text{TeO}_2\text{--}0.25\text{V}_2\text{O}_5\text{--}(25 - x)\text{B}_2\text{O}_3\text{--}x\text{Nd}_2\text{O}_3$ ($x = 0, 0.5, 1, 1.5$ mol%) glass system were determined using Phy-X PSD [19] code and MCNPX [20–22] Monte Carlo code. Tellur-based glasses usually start to deteriorate and burn at high temperatures (about 900 °C) and accordingly they become a blackish color. The synthesis temperature rises when Nd_2O_3 rises above certain ratios. Therefore, the Nd_2O_3 reinforcement amount is kept at low rates so as not to exceed high temperatures. The main priority was a consideration of their elemental mass fractions (wt%) and material densities (see Table 1). The results of MAC determination obtained from Phy-X PSD and MCNPX can be seen in Table 2. Overall, average MAC values were obtained in a clear pattern and consensus. However, different smooth findings were recorded between the Phy-X-PSD code and the MCNPX Monte Carlo code. This situation can be clarified by the kinds of processes and physics lists MCNP uses in Monte Carlo simulation and random event generator for a process of radiation transport, while Phy-X PSD is a mechanism that uses statistical equations for direct determination of MAC values. Moreover, its worth mentioning that MAC values used in Phy-X PSD calculations are taken from the NIST

(National Institute of Standard and Technology) database. There is no direct outcome to record MAC values in MCNPX code, but another sub-calculation is done through analysis of the output file. Monte Carlo simulations were generated by incorporating the main details, including input files, cell cards, and source information. Glass samples were determined in terms of their elemental mass percentage, material density, and geometric shape. In respect to radiation interaction, we must discuss the concerns of shielding and nuclear protection. Data on the simulation must be detailed in a systematic graph. The expertise required to describe physical quantities and identify the specific input point. The arrangement of the gamma-ray emitting systems can be seen in Figure 1. In this measurement, the accurate F4 Tally mesh was used. This approach allows for the analysis of the average photon flux in a cell. Moreover, a point isotropic source was defined as a gamma-ray emitter. Mass attenuation coefficients of studied glasses were determined in few stages such as definition of gamma-ray transmission setup, simulation run, and analysing of outcome file. The gamma-ray transmission setup was designed considering the experimental conditions, where the terms of collimation and Pb shields are important. The 3-D view of gamma-ray transmission setup was checked using MCNPX visual editor. Initial checks showed that this model does not have any geometric errors or design problems. The simulation run was repeated for every single glass sample at different gamma-ray energies. Finally, a detailed analysis was performed in output file. To measure the attenuation coefficient, primary and secondary gamma-ray fluxes were exported from the output file.

Table 1. Chemical compositions and density for glass samples.

Glass Code	mol%					wt%				Density (g/cm ³)
	V ₂ O ₅	TeO ₂	B ₂ O ₃	Nd ₂ O ₃	B	O	V	Te	Nd	
VTBNd0.0	0.25	74.75	25	0	0.03941	0.26333	0.00186	0.69541	0.00000	4.7015
VTBNd0.5	0.25	74.75	24.5	0.5	0.03825	0.26079	0.00184	0.68871	0.01041	4.9031
VTBNd1.0	0.25	74.75	24	1	0.03711	0.25830	0.00182	0.68214	0.02063	4.9130
VTBNd1.5	0.25	74.75	23.5	1.5	0.03599	0.25586	0.00180	0.67569	0.03065	4.9465

Table 2. Mass attenuation coefficients (MAC) of studied glass samples obtained from MCNPX code and Phy-X PSD program.

Energy (MeV)	VTBNd0.0		VTBNd0.5		VTBNd1.0		VTBNd1.5	
	Phy-X PSD	MCNPX	Phy-X PSD	MCNPX	Phy-X PSD	MCNPX	Phy-X PSD	MCNPX
0.015	35.8866	38.6955	36.3656	38.8954	36.8356	39.0214	37.2966	39.1225
0.02	16.5527	17.0157	16.7767	17.0954	16.9964	17.1021	17.2119	17.2320
0.03	5.5968	5.6124	5.6725	5.6234	5.7468	5.7512	5.8197	5.8216
0.04	14.4372	14.5126	14.3585	14.5124	14.2813	14.5216	14.2055	14.5329
0.05	8.0274	8.0954	8.1218	8.1325	8.2143	8.2245	8.3051	8.3129
0.06	4.9539	4.9624	5.0136	5.0526	5.0722	5.1024	5.1296	5.1315
0.08	2.3143	2.3221	2.3423	2.3521	2.3697	2.3721	2.3967	2.4018
0.10	1.2992	1.3054	1.3146	1.3204	1.3297	1.3412	1.3444	1.3458
0.15	0.4927	0.4953	0.4977	0.0501	0.5027	0.5049	0.5076	0.5082
0.20	0.2757	0.2768	0.2780	0.2796	0.2803	0.2824	0.2825	0.2831
0.30	0.1490	0.1504	0.1497	0.1510	0.1505	0.1524	0.1512	0.1525
0.40	0.1097	0.1102	0.1101	0.1115	0.1104	0.1116	0.1107	0.1119
0.50	0.0912	0.0923	0.0914	0.0924	0.0916	0.0926	0.0917	0.0928
0.60	0.0801	0.0816	0.0802	0.0818	0.0803	0.0821	0.0804	0.0823
0.80	0.0668	0.0671	0.0669	0.0710	0.0669	0.0711	0.0670	0.0712
1.00	0.0586	0.0592	0.0587	0.0598	0.0587	0.0599	0.0587	0.0601
1.50	0.0471	0.0482	0.0471	0.0485	0.0471	0.0487	0.0471	0.0489
2.00	0.0413	0.0426	0.0413	0.0428	0.0413	0.0429	0.0413	0.0430
3.00	0.0359	0.0362	0.0359	0.0363	0.0360	0.0365	0.0360	0.0366

Table 2. Cont.

	VTBNd0.0		VTBNd0.5		VTBNd1.0		VTBNd1.5	
Energy (MeV)	Phy-X PSD	MCNPX	Phy-X PSD	MCNPX	Phy-X PSD	MCNPX	Phy-X PSD	MCNPX
4.00	0.0336	0.0341	0.0337	0.0343	0.0337	0.0346	0.0338	0.0348
5.00	0.0326	0.0334	0.0327	0.0336	0.0327	0.0339	0.0328	0.0341
6.00	0.0322	0.0325	0.0323	0.0328	0.0324	0.0331	0.0325	0.0332
8.00	0.0324	0.0326	0.0325	0.0327	0.0326	0.0329	0.0327	0.0330
10.00	0.0331	0.0334	0.0332	0.0335	0.0333	0.0336	0.0334	0.0337
15.00	0.0354	0.0356	0.0355	0.0358	0.0357	0.0360	0.0358	0.0361

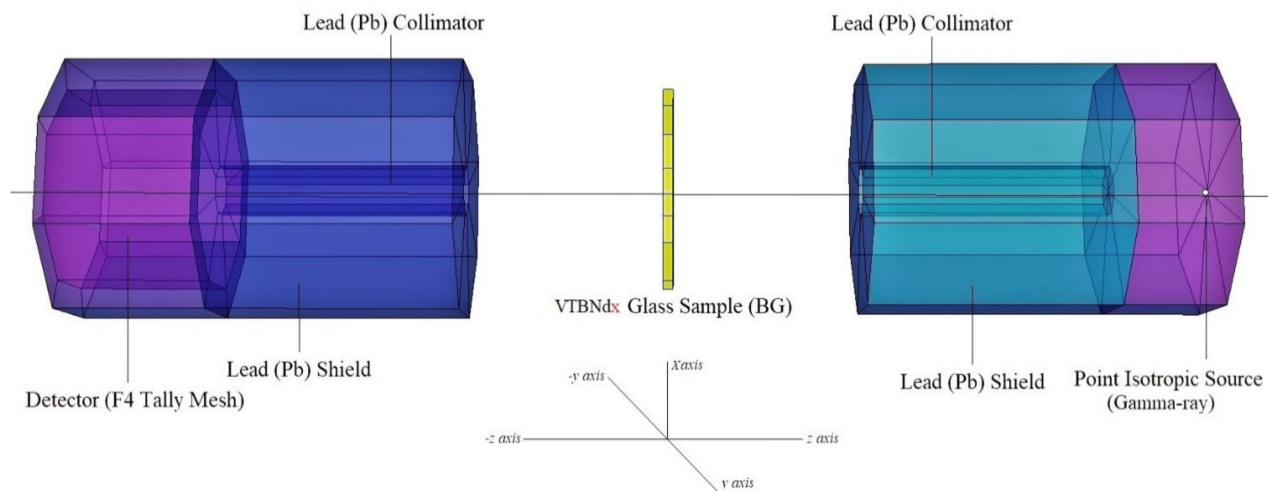


Figure 1. MCNPX simulation setup for gamma-ray transmission studies (MCNPX Visual Editor).

2.2. Shielding Parameters

If the attenuator is located between the detector and the source, the amplitude of the primary gamma-ray decreases exponentially according to the Beer-Lambert law [23,24]:

$$I = I_0 e^{-\mu x} \quad (1)$$

I_0 is the intensity of primary gamma, while I is the intensity of transmitted gamma through the glass. In addition, μ indicates the linear attenuation coefficient of the energy of interest. The definition of x is the attenuator thickness. When it comes to a compound, the mass attenuation coefficients are calculated as [25,26]:

$$MAC = \sum_i w_i (MAC)_i \quad (2)$$

The term w_i represents weight fraction of the i th constitute elements.

The total effective atomic cross-section was determined by taking into account the effective atomic number, effective electron density depending on the total molecular cross-section (σ_t), and the total electronic cross-section (σ_a) [27–29].

$$\sigma_t = \frac{1}{N_A} \sum_i n_i A_i (MAC)_i \quad (3)$$

$$\sigma_a = \frac{1}{N_A} \sum_i f_i A_i (MAC)_i \quad (4)$$

$$\sigma_e = \frac{1}{N_A} \sum_i \frac{f_i A_i}{Z_i} (MAC)_i \quad (5)$$

$$Z_{eff} = \frac{\sigma_a}{\sigma_e} \quad (6)$$

$$N_{eff} = \frac{(MAC)}{\sigma_e} \quad (7)$$

The used parameters are as follow:

n_i : number of atoms

A_i : atomic weight

Z_i : atomic number

f_i : fractional abundance of i th element

N_A : Avogadro number

A certain attenuator thickness will decrease the absorbed gamma strength by a factor of two; this is called the half-value layer, and it is a function of distance from the source [9,30]:

$$HVL = \frac{\ln(2)}{LAC} \quad (8)$$

The term one mean free path (MFP) describes an absorption of 0.368 of the initial gamma radiation [31,32]:

$$MFP = \frac{1}{LAC} \quad (9)$$

As a vital gamma ray shielding parameters exposure buildup factor (EBF), energy absorption buildup factor (EABF) is also a remarkable shielding parameter to obtain total contributions to gamma attenuation rays in a material environment. Currently, exposure buildup factor (EBF) and energy absorption buildup factor (EABF) parameters were also calculated using the Geometry-Progressive (G-P) fitting method. A thorough explanation of the above mechanism can be found in our previous reports.

3. Results

In this study, four different glass samples encoded VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 based on $74.75\text{TeO}_2-0.25\text{V}_2\text{O}_5-(25-x)\text{B}_2\text{O}_3-x\text{Nd}_2\text{O}_3$ ($x = 0, 0.5, 1, 1.5$ mol%) systems were tested for their feasibility for nuclear radiation shielding utilizations. The experiments on optical and structural properties were widely reported, which included alloys of different composition. In a previous paper, Kilic [1] discussed the effect of B_2O_3 and Nd_2O_3 substitution on the optical, structural, and thermal properties of these glass samples. He discovered a personal association between Nd_2O_3 reinforcement and the optical properties and thermal and structural properties of $74.75\text{TeO}_2-0.25\text{V}_2\text{O}_5-(25-x)\text{B}_2\text{O}_3-x\text{Nd}_2\text{O}_3$ ($x = 0, 0.5, 1, 1.5$ mol%) oxide glasses. To fulfil the demands of IAEA and WHO organizations, the importance of alternative shielding materials is rising. This study attempted to investigate the connection between the intriguing results in the Nd_2O_3 reinforced oxide glasses and their nuclear radiation shielding properties. A first move was made in evaluating availability concentrations for alloys in a 0.015–15 MeV range, using a general-purpose Monte Carlo method and Phy-X software. The selected energy range is a standard energy range of theoretical gamma ray shielding calculations, where the critical behaviors at the low, middle, and high energy region depending on dominant interaction processes such as photoelectric effect, Compton scattering, and pair production can be observed. The word 'LAC' (μ) is used to measure the shielding efficacy of glass samples. Density relies on the effectiveness of shielding compounds and the energy of the gamma rays. Figure 2 shows the interaction between the photon energy of VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 samples. In Figure 2, the energy zone's effect on the variance of the LAC value was affected by the photoelectric effect, Compton scattering, and pair production mechanisms. This result occurs due to the nature of radiation's interaction with matter. At low energies, the LAC value is decreased because of photo adsorption. In the mid-energy region, Compton scattering was the dominant interaction in the measurement pattern. However, the highest LAC amount was calculated in the VTBNd1.5 sample, which has the

highest concentration of Nd_2O_3 . The mass attenuation coefficient (MAC) of the specified substance is density-independent and unique.

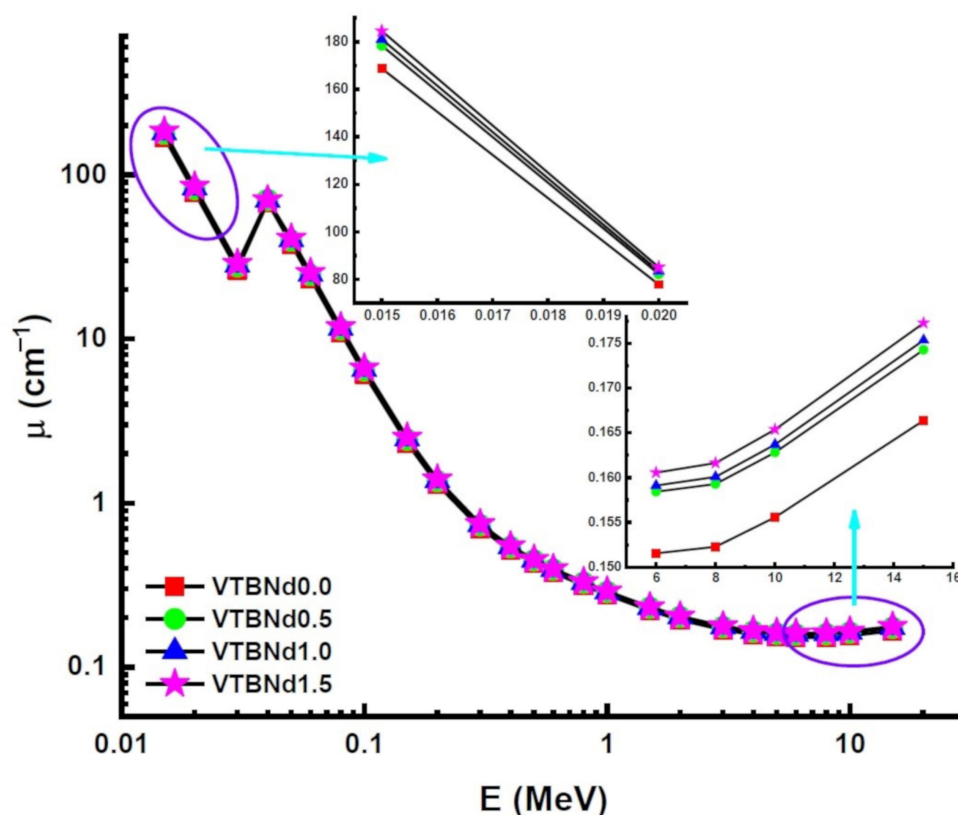


Figure 2. Variation of linear attenuation coefficient (μ) against photon energy for all glasses.

Figure 3 displays the variation of obtained MAC values against photon energy (E). A variety of gamma-ray radiation and chemical compositions of attenuator glass have changed the rate of difference of MAC values. The landscape of the MAC data reveals noticeable trends in distinct areas. In the low energy area where the photoelectric effect determines how much gamma ray is absorbed, the absorption decreased significantly. Compton scattering dominance showed statistically substantial declines from MAC values. It appears that the VTBNd1.5 sample has higher MAC values at all incident photon energies. In particular, the findings for VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 samples were reported as 0.4926, 0.4977, 0.5027, and 0.5075 at 0.15 MeV photon energy, respectively. Moreover, MAC values were reported as 0.0353, 0.0355, 0.0356, and 0.0358 at 15 MeV photon energy for the studied glass samples in the same order. The condition obtained in both low and high energy areas can be explained by the inclusion of the largest amount of Nd_2O_3 in the glass composition because of its high atomic number. Similar results were reported by Elmahroug et al. [13]. Their results showed that Bi_2O_3 reinforcement in the V_2O_5 – TeO_2 glass system directly increased the mass attenuation coefficients of the studied glasses. Similar to our results, an increasing reinforcement amount with higher atomic number resulted in an increment in the V_2O_5 – TeO_2 glass system. The term HVL factor is a useful quantity to evaluate the required thickness of a shield, which can reduce the intensity of the incident gamma ray by half. Therefore, a smaller HVL can be considered as a supremacy indicator in shielding materials. In this study, HVL values of the studied glasses were determined. Figure 4 shows a variation of the half value layer ($T_{1/2}$) against photon energy for all glasses. In the lower energies, HVL values were reported as small. This is an expected situation for any type of shielding material as low energy gamma rays can be attenuated in low material thicknesses. However, it can be seen from Figure 4 that HVL values are higher in the high energy zone.

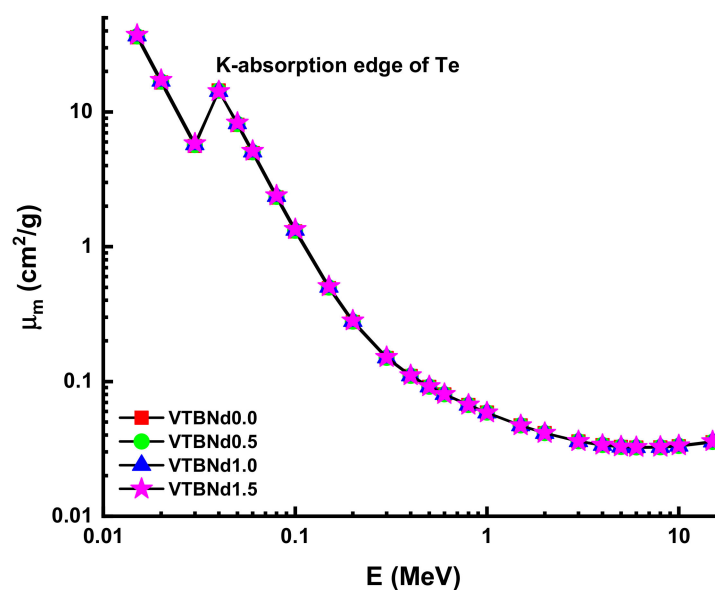


Figure 3. Variation of mass attenuation coefficient (μ_m) against photon energy for all glasses.

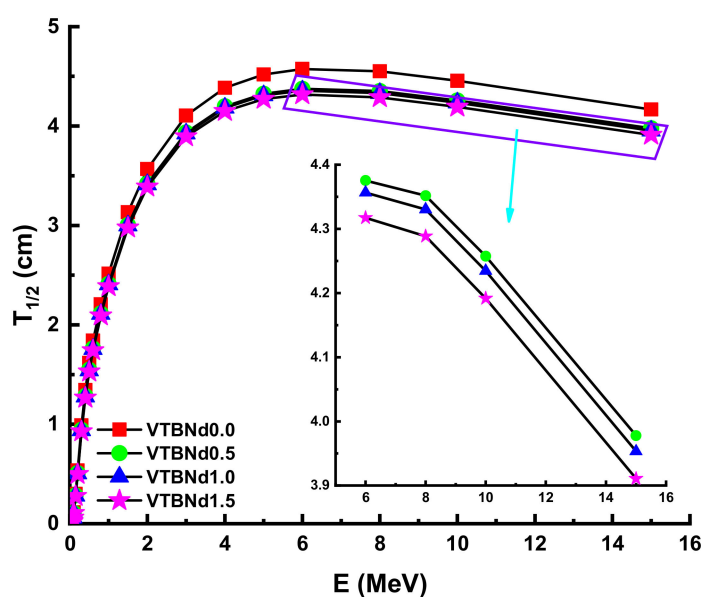


Figure 4. Variation of half value layer ($T_{1/2}$) against photon energy for all glasses.

It can be explained by the penetration property of gamma rays and its dependence on energy. For example, the HVL values of the VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 samples at different energies were found to be $0.0041 \text{ cm HVL}_{\text{VTBNd0.0}} > 0.0039 \text{ cm HVL}_{\text{VTBNd0.5}} > 0.0038 \text{ cm HVL}_{\text{VTBNd1.0}} > 0.0037 \text{ cm HVL}_{\text{VTBNd1.5}}$ at 0.015 MeV. Moreover, HVL values were reported as $0.2992 \text{ cm HVL}_{\text{VTBNd0.0}} > 0.2840 \text{ cm HVL}_{\text{VTBNd0.5}} > 0.2806 \text{ cm HVL}_{\text{VTBNd1.0}} > 0.2760 \text{ cm HVL}_{\text{VTBNd1.5}}$ at 0.15 MeV. Finally, HVL values were reported as $4.1660 \text{ cm HVL}_{\text{VTBNd0.0}} > 3.9777 \text{ cm HVL}_{\text{VTBNd0.5}} > 3.9533 \text{ cm HVL}_{\text{VTBNd1.0}} > 3.9106 \text{ cm HVL}_{\text{VTBNd1.5}}$ at 15 MeV, respectively. As shown from this ranking, the minimum HVL values were reported for the VTBNd1.5 sample, which has the highest amount of Nd_2O_3 additive in its glass structure. Therefore, one can say that VTBNd1.5 requires the smallest thickness to reduce incident gamma rays by half ($T_{1/2}$). The importance of the mean free path (λ) is a consideration in the gamma-protection abilities of shielding materials. The glass samples were examined, and the results are detailed in Figure 5.

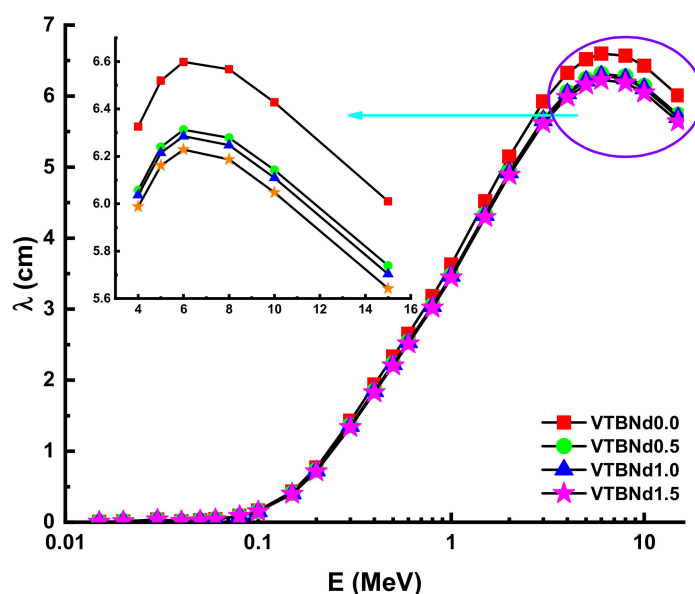


Figure 5. Variation of mean free path (λ) against photon energy for all glasses.

The λ values will differ similarly to the evolving pattern of HVL. The minimum λ values were recorded for the VTBNd1.5 sample. Another important shielding parameter is the tenth value layer (TVL). The term TVL factor is another essential evaluation criterion for the required thickness of a shield, reducing the intensity of an incident gamma ray to one-tenth (1/10). TVL values of the studied glasses were determined and the results presented in Figure 6 as a function of the incident photon energy for all glasses. In the lower energies, TVL values were reported as small. A similar variation trend of HVL was also reported for the TVL values of the VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 samples. For example, TVL values were reported as 0.9941 cm $\text{TVL}_{\text{VTBNd0.0}} > 0.9435$ cm $\text{TVL}_{\text{VTBNd0.5}} > 0.9323$ cm $\text{TVL}_{\text{VTBNd1.0}} > 0.9170$ cm $\text{HVL}_{\text{VTBNd1.5}}$ at 0.15 MeV. Overall, the minimum TVL values were reported for the VTBNd1.5 sample, which has the highest amount of Nd_2O_3 additive. The required atomic number for measuring the material's appropriateness for gamma applications is tied to the proper photon control stage. The Z_{eff} values of the glass samples measured are shown in Figure 7.

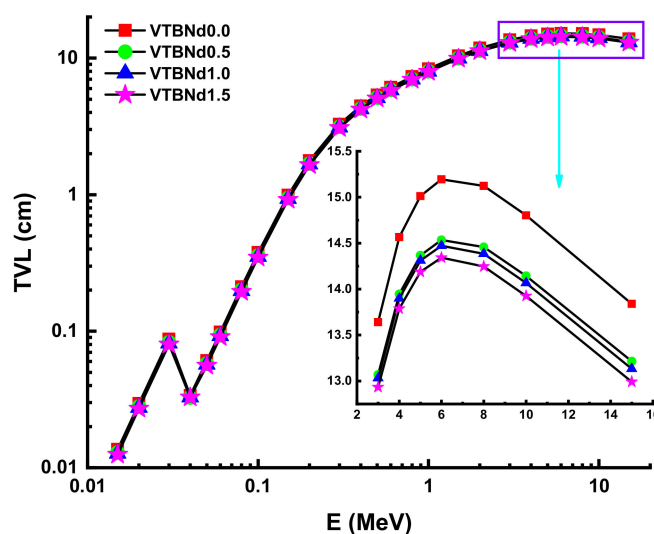


Figure 6. Variation of tenth value layer (TVL) against photon energy for all glasses.

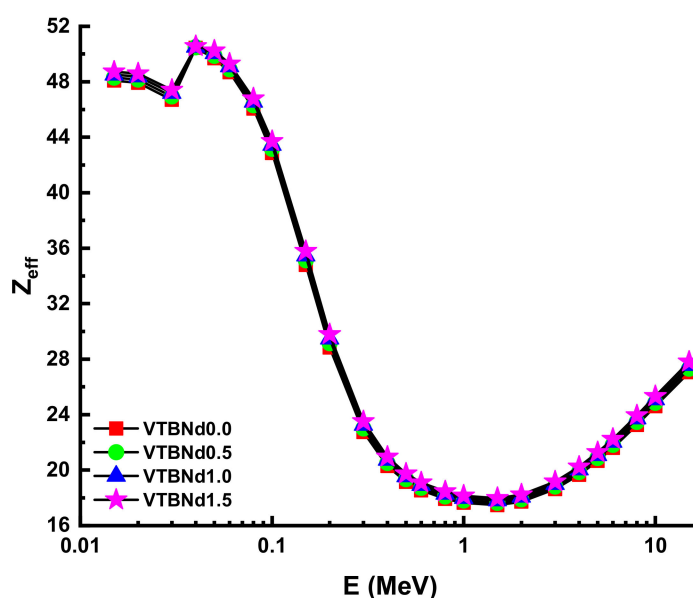


Figure 7. Variation of effective atomic number (Z_{eff}) against photon energy for all glasses.

Thanks to its high-quality shading properties, Z_{eff} values were greatest for the VTBNd1.5 glass sample. For example, Z_{eff} values for VTBNd1.5 were 34.80, 35.13, 35.46, and 35.78 for the VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 samples at 0.15 MeV, respectively. However, the highest Z_{eff} values were reported at 0.04 MeV as 50.44, 50.48, 50.52, and 50.55 for the VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 samples. The particle concentration in the medium is calculated, and then a radiation density correction is used in the equation to account for scattered radiation. Secondary ionizing radiation must be included in the overall calculation of buildup. The buildup factor is a multiplier compounded by the photon's attenuation rate to calculate the photon's total attenuation. The moderator allows for the disparity in the numbers of photons between the sources that makes up for their different intensities. Using the two sub terms of energy absorption, it can be classified into two forms of energy absorption factor, energy absorption buildup factor (EABF) and exposure buildup factor (EBF). In this study, EBF and EABF values were measured using a G-P fit approach from 0.5 to 40 mfp. The obtained fitting parameters along with their numerical values can be seen in Tables 3–6. Figure 8a–e or Figure 9a–e display the calculated EBF and EABF values against photon energy for the VTBNd0.0, VTBNd0.5, VTBNd1.0, and VTBNd1.5 samples. Figure 8a–e or Figure 9a–e illustrate the concentration of the three distinct constituent layers of EBF and EABF due to photon radiation. Areas affected by gamma rays are important to the connections between radiation and matter. Since the photoelectric effect can be ignored near the binding energy of high atomic numbers, peaks can be observed in the first region. On the other side, though, the third segment of the sample is the most interesting during pair growth, with the value declining due to absorption processes.

Table 3. (Exposure buildup factor (EBF) and energy absorption buildup factor (EABF)) G-P fitting coefficients (b, c, a, X_k and d) of VTBNd0.0 glass sample.

Energy (MeV)	Z_{eq}	G-P Fitting Parameters for EBF					G-P Fitting Parameters for EABF				
		a	b	c	d	X_k	a	b	c	d	X_k
0.015	22.82	0.268	1.005	1.081	0.241	6.312	0.261	1.005	1.075	0.232	7.651
0.020	23.00	0.414	1.014	0.275	−0.368	11.156	0.285	1.013	0.310	−0.240	14.969
0.030	23.34	0.205	1.040	0.373	−0.235	22.020	0.246	1.039	0.336	−0.173	16.382
0.040	43.03	0.089	3.890	0.447	−0.045	23.780	0.104	1.513	0.451	−0.042	21.844
0.050	43.58	−0.191	3.189	0.134	−0.006	12.982	−0.062	1.437	0.145	0.046	10.070
0.060	43.95	0.808	2.548	0.064	−0.124	14.259	0.571	1.390	0.084	−0.127	16.541

Table 3. Cont.

Energy (MeV)	Z_{eq}	G-P Fitting Parameters for EBF					G-P Fitting Parameters for EABF				
		a	b	c	d	X_k	a	b	c	d	X_k
0.080	44.43	0.781	1.708	0.028	−0.223	14.739	0.625	1.330	0.066	−0.228	14.105
0.100	44.73	0.434	1.244	0.212	−0.216	13.764	0.448	1.246	0.186	−0.237	13.653
0.150	45.19	0.218	1.232	0.421	−0.118	14.223	0.346	1.443	0.262	−0.191	13.999
0.200	45.43	0.172	1.378	0.508	−0.096	14.439	0.322	1.984	0.296	−0.195	13.980
0.300	45.72	0.093	1.499	0.691	−0.046	14.364	0.181	2.158	0.509	−0.107	13.943
0.400	45.88	0.052	1.620	0.839	−0.038	14.160	0.129	2.466	0.651	−0.098	13.890
0.500	45.96	0.030	1.689	0.923	−0.030	14.190	0.088	2.524	0.766	−0.075	13.884
0.600	46.02	0.014	1.717	0.977	−0.022	13.982	0.065	2.518	0.831	−0.063	13.744
0.800	46.08	0.001	1.740	1.034	−0.016	14.057	0.040	2.421	0.912	−0.048	13.644
1.000	46.11	−0.006	1.731	1.058	−0.013	13.430	0.027	2.310	0.954	−0.039	13.523
1.500	45.02	−0.026	1.602	1.145	−0.001	9.989	−0.005	1.931	1.070	−0.018	13.546
2.000	42.24	−0.021	1.600	1.126	−0.006	12.636	0.003	1.850	1.046	−0.025	13.072
3.000	38.97	−0.001	1.569	1.064	−0.026	12.712	0.027	1.710	0.973	−0.049	13.020
4.000	37.73	0.014	1.517	1.023	−0.038	13.233	0.041	1.583	0.938	−0.061	13.682
5.000	37.08	0.036	1.506	0.964	−0.057	13.479	0.062	1.530	0.887	−0.080	13.905
6.000	36.63	0.044	1.471	0.948	−0.064	13.602	0.069	1.465	0.875	−0.086	14.111
8.000	36.13	0.063	1.459	0.911	−0.081	13.886	0.081	1.402	0.860	−0.094	14.192
10.000	35.86	0.052	1.411	0.964	−0.070	14.082	0.067	1.333	0.912	−0.081	14.341
15.000	35.75	0.042	1.407	1.053	−0.062	14.299	0.060	1.291	0.986	−0.075	14.511

Table 4. (EBF and EABF) G-P fitting coefficients (b, c, a, X_k and d) of VTBNd0.5 glass sample.

Energy (MeV)	Z_{eq}	G-P Fitting Parameters for EBF					G-P Fitting Parameters for EABF				
		a	b	c	d	X_k	a	b	c	d	X_k
0.015	22.94	0.279	1.005	1.100	0.246	6.283	0.273	1.005	1.095	0.237	7.568
0.020	23.12	0.423	1.014	0.269	−0.378	11.166	0.287	1.013	0.308	−0.242	15.108
0.030	23.46	0.204	1.039	0.373	−0.239	22.365	0.246	1.038	0.336	−0.174	16.500
0.040	42.97	0.089	3.893	0.440	−0.044	23.756	0.105	1.511	0.443	−0.042	21.926
0.050	43.78	−0.175	3.199	0.146	−0.014	13.113	−0.051	1.444	0.157	0.036	10.296
0.060	44.16	0.778	2.562	0.070	−0.121	13.922	0.547	1.396	0.090	−0.121	16.709
0.080	44.64	0.782	1.712	0.027	−0.220	14.767	0.629	1.332	0.065	−0.228	14.110
0.100	44.93	0.444	1.250	0.205	−0.220	13.765	0.456	1.249	0.182	−0.242	13.643
0.150	45.40	0.221	1.231	0.417	−0.119	14.210	0.350	1.443	0.259	−0.193	13.993
0.200	45.64	0.172	1.372	0.507	−0.096	14.447	0.322	1.967	0.296	−0.195	13.978
0.300	45.93	0.093	1.495	0.689	−0.047	14.357	0.183	2.146	0.506	−0.107	13.937
0.400	46.08	0.052	1.615	0.836	−0.038	14.159	0.130	2.456	0.648	−0.098	13.889
0.500	46.17	0.031	1.685	0.920	−0.030	14.183	0.089	2.516	0.763	−0.076	13.884
0.600	46.23	0.015	1.713	0.975	−0.022	13.984	0.066	2.511	0.828	−0.063	13.743
0.800	46.29	0.001	1.737	1.032	−0.016	14.059	0.041	2.417	0.910	−0.048	13.643
1.000	46.32	−0.005	1.728	1.057	−0.014	13.430	0.027	2.307	0.952	−0.040	13.522
1.500	45.25	−0.026	1.601	1.144	−0.001	10.192	−0.005	1.931	1.068	−0.019	13.551
2.000	42.50	−0.021	1.598	1.126	−0.006	12.652	0.003	1.850	1.044	−0.025	13.073
3.000	39.23	−0.001	1.568	1.064	−0.026	12.724	0.028	1.711	0.972	−0.050	13.037
4.000	37.99	0.014	1.516	1.023	−0.038	13.241	0.042	1.584	0.936	−0.062	13.672
5.000	37.34	0.036	1.506	0.963	−0.058	13.485	0.063	1.532	0.884	−0.082	13.897
6.000	36.88	0.044	1.473	0.947	−0.065	13.613	0.070	1.467	0.872	−0.087	14.105
8.000	36.39	0.064	1.462	0.910	−0.082	13.898	0.082	1.406	0.857	−0.095	14.197
10.000	36.11	0.052	1.415	0.964	−0.070	14.088	0.068	1.337	0.911	−0.082	14.342
15.000	36.01	0.042	1.414	1.056	−0.062	14.293	0.061	1.296	0.987	−0.076	14.500

Table 5. (EBF and EABF) G-P fitting coefficients (b, c, a, X_k and d) of VTBNd1.0 glass sample.

Energy (MeV)	Z _{eq}	G-P Fitting Parameters for EBF					G-P Fitting Parameters for EABF				
		a	b	c	d	X _k	a	b	c	d	X _k
0.015	23.06	0.291	1.005	1.119	0.250	6.255	0.285	1.005	1.114	0.242	7.487
0.020	23.24	0.432	1.014	0.263	−0.389	11.176	0.288	1.013	0.306	−0.245	15.242
0.030	23.58	0.203	1.039	0.373	−0.243	22.698	0.246	1.038	0.335	−0.174	16.614
0.040	42.91	0.089	3.896	0.432	−0.044	23.732	0.105	1.510	0.435	−0.043	22.005
0.050	43.98	−0.159	3.209	0.158	−0.022	13.239	−0.039	1.451	0.168	0.027	10.514
0.060	44.36	0.748	2.576	0.076	−0.119	13.595	0.524	1.403	0.096	−0.114	16.873
0.080	44.84	0.783	1.716	0.027	−0.217	14.794	0.633	1.335	0.063	−0.228	14.115
0.100	45.14	0.454	1.256	0.199	−0.224	13.767	0.465	1.253	0.177	−0.247	13.633
0.150	45.60	0.223	1.231	0.413	−0.121	14.199	0.353	1.443	0.255	−0.195	13.987
0.200	45.84	0.172	1.367	0.507	−0.096	14.456	0.322	1.951	0.295	−0.195	13.975
0.300	46.13	0.094	1.490	0.687	−0.047	14.350	0.184	2.134	0.504	−0.108	13.931
0.400	46.28	0.053	1.611	0.834	−0.038	14.158	0.132	2.445	0.645	−0.099	13.888
0.500	46.37	0.031	1.680	0.917	−0.030	14.177	0.090	2.508	0.760	−0.076	13.883
0.600	46.43	0.016	1.709	0.973	−0.022	13.986	0.067	2.505	0.825	−0.063	13.743
0.800	46.49	0.001	1.734	1.030	−0.016	14.061	0.041	2.413	0.907	−0.048	13.643
1.000	46.52	−0.005	1.726	1.055	−0.014	13.430	0.028	2.305	0.950	−0.040	13.521
1.500	45.46	−0.026	1.599	1.143	−0.002	10.389	−0.004	1.930	1.067	−0.019	13.556
2.000	42.75	−0.020	1.596	1.125	−0.006	12.669	0.004	1.850	1.042	−0.026	13.075
3.000	39.49	−0.001	1.567	1.064	−0.026	12.735	0.029	1.712	0.970	−0.051	13.054
4.000	38.25	0.014	1.515	1.023	−0.039	13.249	0.043	1.585	0.934	−0.063	13.661
5.000	37.60	0.037	1.507	0.962	−0.058	13.491	0.065	1.534	0.881	−0.083	13.891
6.000	37.14	0.045	1.474	0.946	−0.065	13.624	0.072	1.470	0.868	−0.089	14.100
8.000	36.64	0.065	1.465	0.908	−0.082	13.910	0.083	1.410	0.854	−0.097	14.202
10.000	36.37	0.052	1.419	0.964	−0.070	14.094	0.069	1.340	0.909	−0.083	14.342
15.000	36.26	0.042	1.421	1.059	−0.062	14.287	0.061	1.301	0.989	−0.076	14.490

Table 6. (EBF and EABF) G-P fitting coefficients (b, c, a, X_k and d) of VTBNd1.5 glass sample.

Energy (MeV)	Z _{eq}	G-P Fitting Parameters for EBF					G-P Fitting Parameters for EABF				
		a	b	c	d	X _k	a	b	c	d	X _k
0.015	23.17	0.302	1.005	1.137	0.254	6.228	0.296	1.005	1.133	0.247	7.409
0.020	23.35	0.440	1.014	0.257	−0.399	11.185	0.290	1.013	0.304	−0.247	15.372
0.030	23.69	0.203	1.038	0.373	−0.246	23.020	0.247	1.037	0.334	−0.175	16.724
0.040	42.85	0.089	3.899	0.425	−0.043	23.709	0.105	1.509	0.428	−0.043	22.084
0.050	44.18	−0.144	3.219	0.169	−0.029	13.362	−0.028	1.457	0.179	0.018	10.728
0.060	44.56	0.720	2.590	0.082	−0.117	13.279	0.502	1.409	0.102	−0.108	17.031
0.080	45.03	0.785	1.720	0.027	−0.215	14.820	0.637	1.337	0.062	−0.228	14.120
0.100	45.33	0.464	1.262	0.193	−0.228	13.768	0.473	1.257	0.172	−0.252	13.623
0.150	45.79	0.226	1.230	0.409	−0.122	14.187	0.357	1.443	0.252	−0.197	13.981
0.200	46.03	0.172	1.362	0.507	−0.095	14.464	0.322	1.935	0.294	−0.195	13.972
0.300	46.32	0.095	1.486	0.685	−0.047	14.344	0.185	2.123	0.501	−0.108	13.925
0.400	46.47	0.054	1.607	0.831	−0.039	14.157	0.133	2.435	0.642	−0.099	13.887
0.500	46.56	0.032	1.677	0.915	−0.031	14.170	0.091	2.500	0.757	−0.077	13.882
0.600	46.63	0.016	1.705	0.971	−0.022	13.988	0.068	2.498	0.822	−0.064	13.742
0.800	46.69	0.002	1.731	1.028	−0.016	14.062	0.042	2.409	0.905	−0.049	13.642
1.000	46.71	−0.004	1.724	1.054	−0.014	13.430	0.029	2.302	0.948	−0.040	13.519
1.500	45.68	−0.026	1.598	1.142	−0.002	10.583	−0.004	1.929	1.065	−0.019	13.561
2.000	43.00	−0.020	1.595	1.124	−0.006	12.685	0.004	1.850	1.041	−0.026	13.077
3.000	39.75	−0.001	1.566	1.064	−0.026	12.746	0.029	1.713	0.969	−0.051	13.070
4.000	38.50	0.014	1.515	1.023	−0.039	13.257	0.044	1.586	0.932	−0.064	13.651
5.000	37.85	0.037	1.508	0.961	−0.059	13.497	0.066	1.537	0.878	−0.084	13.884
6.000	37.40	0.046	1.475	0.944	−0.066	13.635	0.073	1.472	0.865	−0.090	14.094
8.000	36.89	0.065	1.469	0.907	−0.083	13.922	0.085	1.413	0.851	−0.098	14.206
10.000	36.63	0.053	1.423	0.964	−0.071	14.099	0.070	1.344	0.908	−0.084	14.343
15.000	36.51	0.041	1.429	1.062	−0.061	14.281	0.061	1.306	0.990	−0.077	14.480

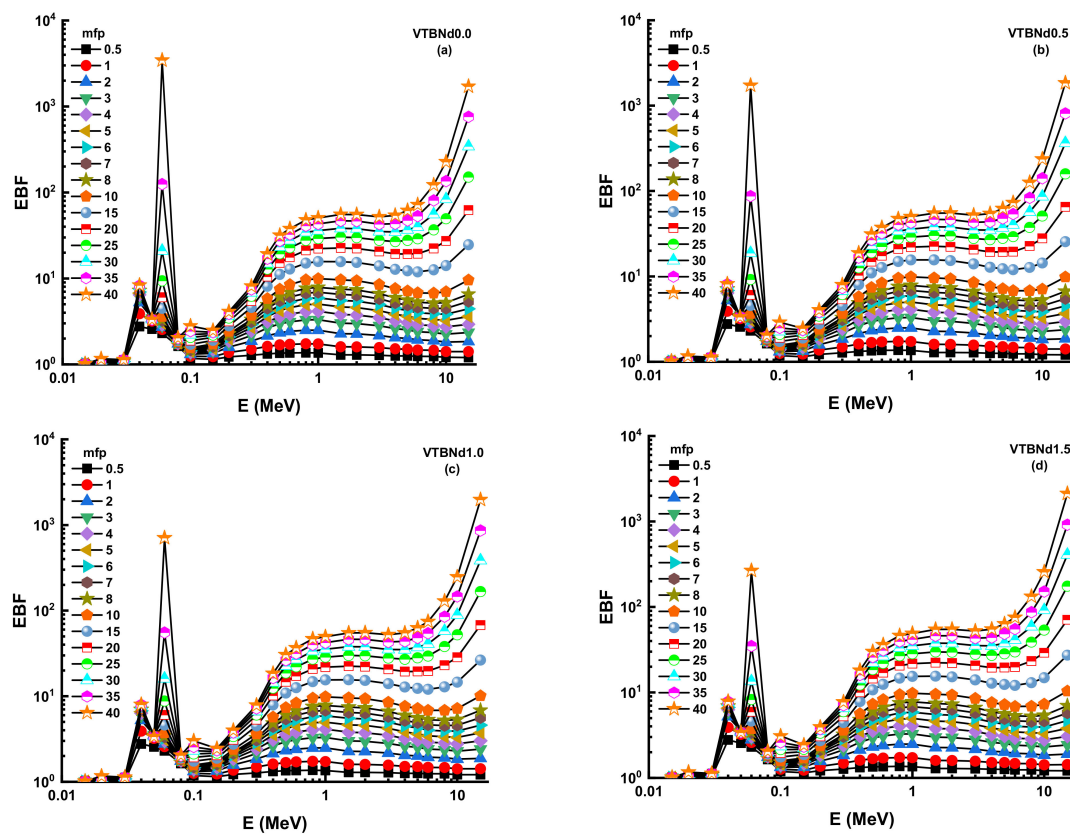


Figure 8. (a–d) Variation of exposure buildup factor (EBF) against photon energy for all glasses.

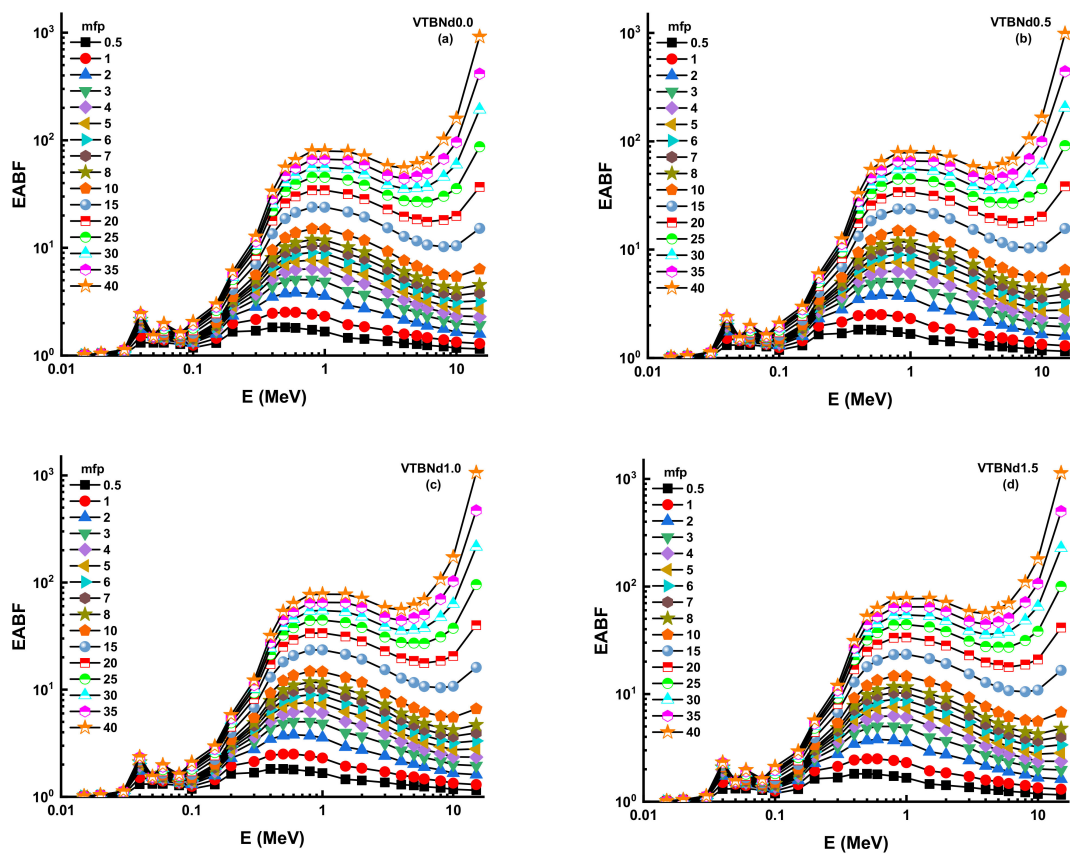


Figure 9. (a–d) Variation of energy absorption buildup factor (EABF) against photon energy for all glasses.

Figures 10 and 11 display the changes in EBF and EABF values of studied glass samples at 10, 20, 30, and 40 mfp. These figures can also be considered as the dependency function of EBF and EABF values against glass structure. Figure 10 shows that VTBNd1.5 has the lowest EBF and EABF values with its superior shielding properties among the investigated glasses. The same pattern was also seen for the EABF value. The minimum EABF values recorded for sample VPBCd8 were found at all mfp values. Analysis was conducted to compare the EBF and EABF values for a set of glass formulations based on mfp values such as 10, 20, 30, and 40 mfp. Figure 12 shows variation of energy absorption buildup factor (EABF) and exposure buildup factor (EBF) against effective atomic number (Z_{eff}) at 1 MeV and 5 mfp for all glasses. It can be clearly seen from Figure 12 that the EBF and EABF is higher for glasses with high Z_{eff} than for glasses with low atomic Z_{eff} . It can be easily shown that there is a strict relationship between EBF values and the efficient atomic number.

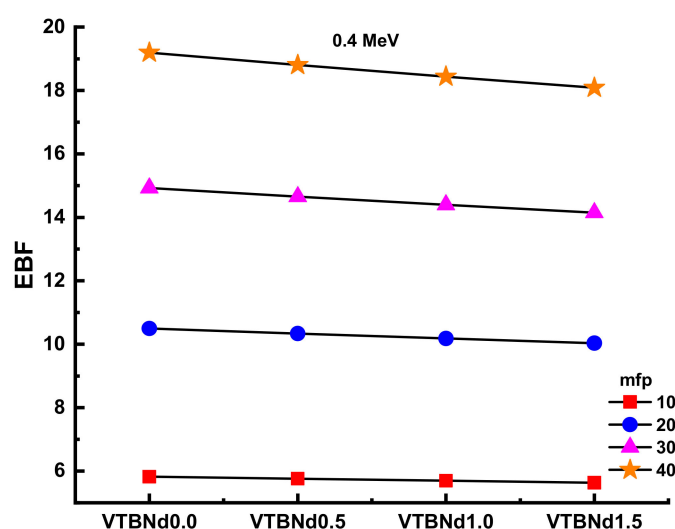


Figure 10. Variation of exposure buildup factor (EBF) against glass compositions.

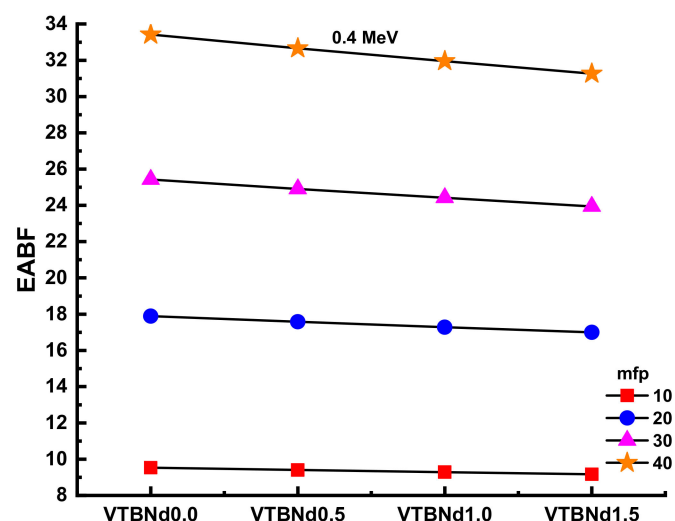


Figure 11. Variation of energy absorption buildup factor (EABF) against glass compositions.

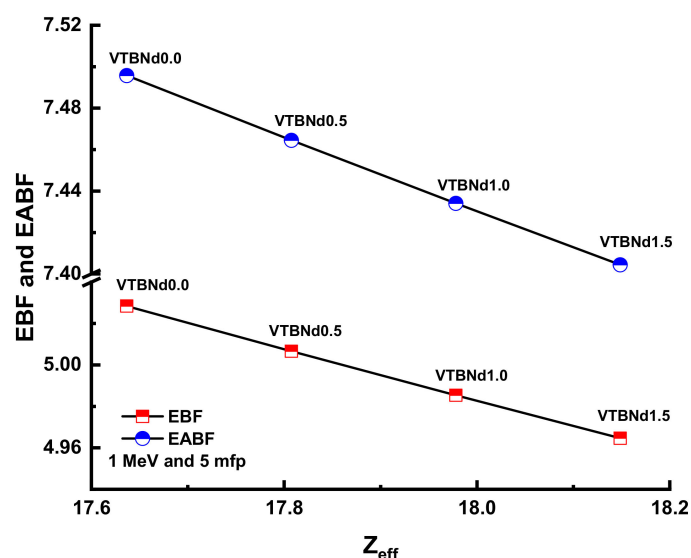


Figure 12. Variation of energy absorption buildup factor (EABF) and exposure buildup factor (EBF) against effective atomic number (Z_{eff}) for all glasses.

4. Conclusions

Nd_2O_3 -doped glasses, among the technologically important lanthanide-doped glasses, are studied frequently due to their luminescence and optical properties. Moreover, among these studies, TeO_2 glasses are mostly preferred due to their excellent optical properties. Being synthesized at low temperatures is one of the many advantages of these glasses. On the other hand, vanadium-doped tellurium glasses with semiconducting properties are considered valuable materials for semiconductor technology and optoelectronic materials such as lasers with the addition of Nd_2O_3 . Apart from these advantageous properties, these glasses' radiation properties were investigated in detail in this study. We aimed to perform a sizeable simulated characterization on a different type of Nd_2O_3 , reinforced glasses and their nuclear radiation shielding properties regarding an ideal shield's essential needs. The effect of varying the ratio of boron (III) oxide and neodymium (III) oxide concentrations on the radiation shielding properties of $\text{TeO}_2\text{--V}_2\text{O}_5\text{--(B}_2\text{O}_3/\text{Nd}_2\text{O}_3)$ were illustrated. The attenuation properties computed at expansive energies within the range of $(0.015\text{--}15) \times 10^3$ keV. Some critical properties, such as $T_{1/2}$, λ , TVL, μ , μ_m , Z_{eff} , EBF, and EABF were determined. Simulated and theoretical μ_m values were obtained using the MXNPX code and the Phy-X PSD database. Good agreement was observed between the simulated and theoretical results. Generally, the VTBNd1.5 sample (1.5 mol%) Nd_2O_3 had the lowest $T_{1/2}$, λ , and TVL values and the highest μ , μ_m , and Z_{eff} values. That means that the VTBNd1.5 sample (with 1.5mol% Nd_2O_3) offers superior shielding against gamma radiation compared to the other samples. The results showed that radiation shielding properties increase according to the doping ratio. As a result of this study, it can be concluded that continuous research is needed in terms of glass sciences and material development studies. The effect of reinforcement was apparent. However, different types of comprehensive investigations with varying additive amounts can be considered as the continuous research of our project on eco-friendly novel shields.

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